

TOSHIBA POWER MOS FET MODULE SILICON N & P CHANNEL MOS TYPE (L²-π-MOS^{IV} 6 IN 1)

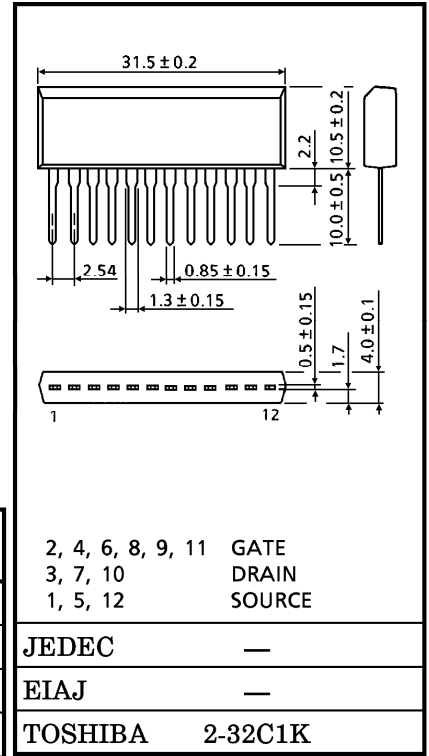
MP6403

HIGH POWER SWITCHING APPLICATION.
3-PHASE MOTOR DRIVE AND BIPOlar DRIVE OF PULSE MOTOR.

INDUSTRIAL APPLICATIONS

Unit in mm

- 4-Volt Gate Drive Available
- Small Package by Full Molding (SIP 12 Pin)
- High Drain Power Dissipation (6 Devices Operation)
: P_T=36W (T_a=25°C)
- Low Drain-Source ON Resistance
: R_{DS(ON)}=90mΩ (Typ.) (N-ch)
170mΩ (Typ.) (P-ch)
- Low Leakage Current: I_{GSS}=±10μA (Max.) (V_{GS}=±16V)
I_{DSS}=100μA (Max.) (V_{DS}=60V)
- Enhancement-Mode : V_{th}=0.8~2.0V (I_D=1mA)

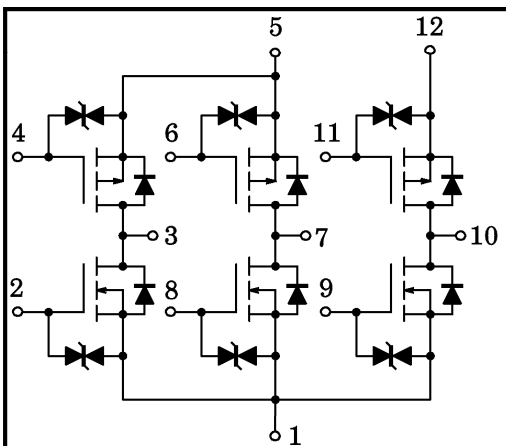


Weight : 3.9g

MAXIMUM RATINGS (T_a = 25°C)

| CHARACTERISTIC | SYMBOL | RATING | | UNIT |
|--|------------------|---------|------|------|
| | | N ch | P ch | |
| Drain-Source Voltage | V _{DSS} | 60 | -60 | V |
| Gate-Source Voltage | V _{GSS} | ±20 | ±20 | V |
| Drain Current | I _D | 5 | -5 | A |
| Peak Drain Current | I _{DP} | 20 | -20 | A |
| Collector Power Dissipation (1 Device Operation) | P _D | 2.2 | | W |
| Collector Power Dissipation (6 Devices Operation) | P _T | 4.4 | | W |
| | | 36 | | |
| Channel Temperature | T _{ch} | 150 | | °C |
| Storage Temperature Range | T _{stg} | -55~150 | | °C |

ARRAY CONFIGURATION

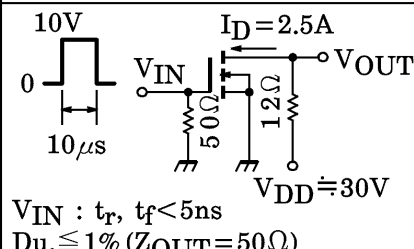


THERMAL CHARACTERISTICS

| CHARACTERISTIC | SYMBOL | MAX. | UNIT |
|--|-----------------------|------|-------------------------------|
| Thermal Resistance of Channel to Ambient (6 Devices Operation, $T_a=25^{\circ}\text{C}$) | $\Sigma R_{th(ch-a)}$ | 28.4 | $^{\circ}\text{C} / \text{W}$ |
| Thermal Resistance of Channel to Case (6 Devices Operation, $T_c=25^{\circ}\text{C}$) | $\Sigma R_{th(ch-c)}$ | 3.47 | $^{\circ}\text{C} / \text{W}$ |
| Maximum Lead Temperature for Soldering Purposes (3.2mm from Case for 10s) | T_L | 260 | $^{\circ}\text{C}$ |

This Transistor is an Electrostatic Sensitive Device. Please Handle with Caution.

ELECTRICAL CHARACTERISTICS (Ta = 25°C) (Nch MOS FET)

| CHARACTERISTIC | | SYMBOL | TEST CONDITION | MIN. | TYP. | MAX. | UNIT |
|---|---------------|---------------|---|---|------|----------|------------|
| Gate Leakage Current | | I_{GSS} | $V_{GS} = \pm 16V, V_{DS} = 0$ | — | — | ± 10 | μA |
| Drain Cut-off Current | | I_{DSS} | $V_{DS} = 60V, V_{GS} = 0$ | — | — | 100 | μA |
| Drain-Source Breakdown Voltage | | $V_{(BR)DSS}$ | $I_D = 10mA, V_{GS} = 0$ | 60 | — | — | V |
| Gate Threshold Voltage | | V_{th} | $V_{DS} = 10V, I_D = 1mA$ | 0.8 | — | 2.0 | V |
| Forward Transfer Admittance | | $ Y_{fs} $ | $V_{DS} = 10V, I_D = 2.5A$ | 3.0 | 6.0 | — | S |
| Drain-Source ON Resistance | | $R_{DS(ON)}$ | $I_D = 2.5A, V_{GS} = 4V$ | — | 135 | 200 | m Ω |
| | | $R_{DS(ON)}$ | $I_D = 2.5A, V_{GS} = 10V$ | — | 90 | 125 | |
| Input Capacitance | | C_{iss} | $V_{DS} = 10V, V_{GS} = 0, f = 1MHz$ | — | 500 | — | pF |
| Reverse Transfer Capacitance | | C_{rss} | | — | 90 | — | |
| Output Capacitance | | C_{oss} | | — | 290 | — | |
| Switching Time | Rise Time | t_r |  | — | 20 | — | ns |
| | Turn-on Time | t_{on} | | — | 60 | — | |
| | Fall Time | t_f | | — | 80 | — | |
| | Turn-off Time | t_{off} | | $V_{IN} : t_r, t_f < 5ns$ $Du \leq 1\% (Z_{OUT} = 50\Omega)$ | — | 300 | |
| Total Gate Charge (Gate-Source Plus Gate-Drain) | | Q_g | $I_D = 5A, V_{GS} = 10V$ $V_{DD} = 48V$ | — | 20 | — | nC |
| Gate-Source Charge | | Q_{gs} | | — | 14 | — | |
| Gate-Drain ("Miller") Charge | | Q_{gd} | | — | 6 | — | |

SOURCE-DRAIN DIODE RATINGS AND CHARACTERISTICS (Ta = 25°C)

| CHARACTERISTIC | SYMBOL | TEST CONDITION | MIN. | TYP. | MAX. | UNIT |
|----------------------------|-----------|-------------------------------|------|------|------|---------|
| Drain Reverse Current | I_{DR} | — | — | — | 5 | A |
| Peak Drain Reverse Current | I_{DRP} | — | — | — | 20 | A |
| Diode Forward Voltage | V_{DSF} | $I_{DR} = 5A, V_{GS} = 0$ | — | — | -1.5 | V |
| Reverse Recovery Time | t_{rr} | $I_{DR} = 5A, V_{GS} = 0$ | — | 140 | — | ns |
| Reverse Recovery Charge | Q_{rr} | $dI_{DR} / dt = -50A / \mu s$ | — | 0.4 | — | μC |

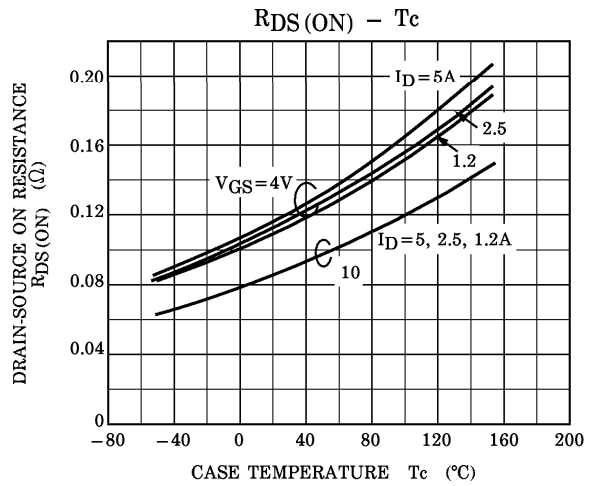
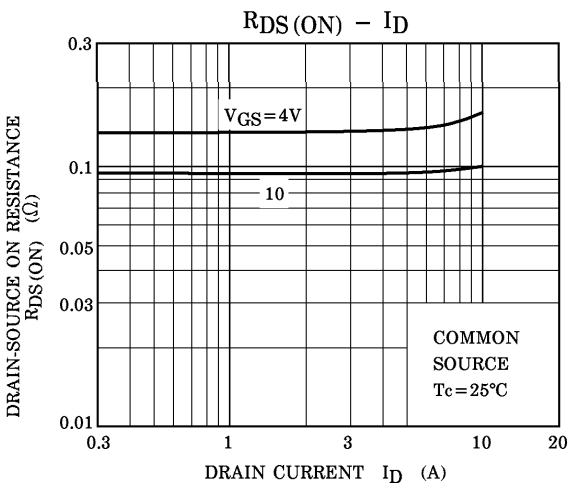
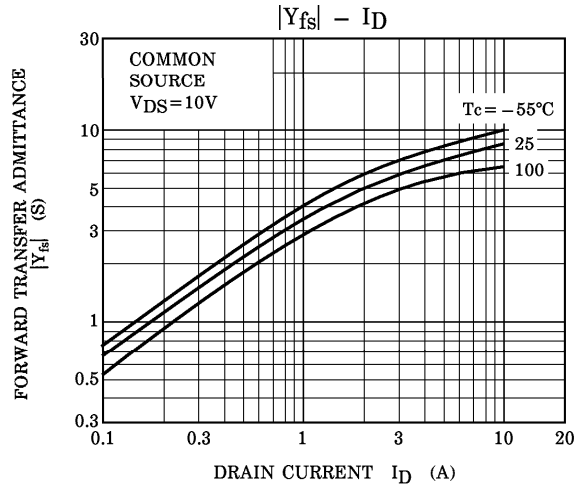
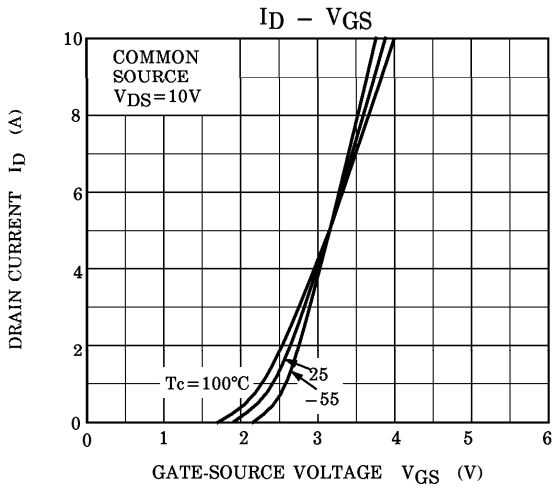
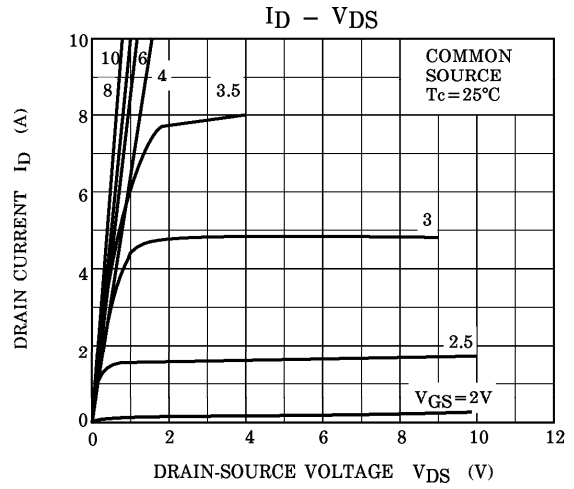
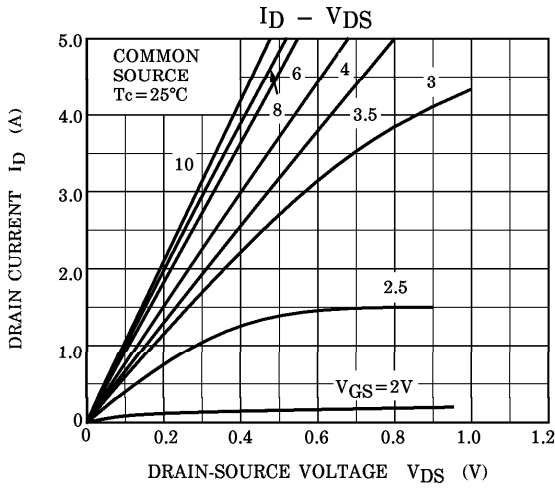
ELECTRICAL CHARACTERISTICS (Ta = 25°C) (Pch MOS FET)

| CHARACTERISTIC | | SYMBOL | TEST CONDITION | MIN. | TYP. | MAX. | UNIT |
|---|---------------|------------------|-------------------------------|---|------|------|------|
| Gate Leakage Current | | IGSS | VGS = ±16V, VDS = 0 | — | — | ±10 | μA |
| Drain Cut-off Current | | IDSS | VDS = -60V, VGS = 0 | — | — | -100 | μA |
| Drain-Source Breakdown Voltage | | V(BR)DSS | ID = -10mA, VGS = 0 | -60 | — | — | V |
| Gate Threshold Voltage | | Vth | VDS = -10V, ID = -1mA | -0.8 | — | -2.0 | V |
| Forward Transfer Admittance | | Yfs | VDS = -10V, ID = -2.5A | 1.0 | 2.0 | — | S |
| Drain-Source ON Resistance | | RDS(ON) | ID = -2.5A, VGS = -4V | — | 250 | 400 | mΩ |
| | | RDS(ON) | ID = -2.5A, VGS = -10V | — | 170 | 245 | |
| Input Capacitance | | Ciss | VDS = -10V, VGS = 0, f = 1MHz | — | 500 | — | pF |
| Reverse Transfer Capacitance | | Crss | | | | | |
| Output Capacitance | | Coss | | | | | |
| Switching Time | Rise Time | tr | | — | 120 | — | ns |
| | Turn-on Time | ton | | — | 130 | — | |
| | Fall Time | tf | | — | 80 | — | |
| | Turn-off Time | t _{off} | | VIN : tr, tf < 5ns Du. ≤ 1% (ZOUT = 50Ω) | — | 200 | |
| Total Gate Charge (Gate-Source Plus Gate-Drain) | | Qg | ID = -5A, VGS = -10V | — | 22 | — | nC |
| Gate-Source Charge | | Qgs | VDD = -48V | — | 14 | — | |
| Gate-Drain ("Miller") Charge | | Qgd | | — | 8 | — | |

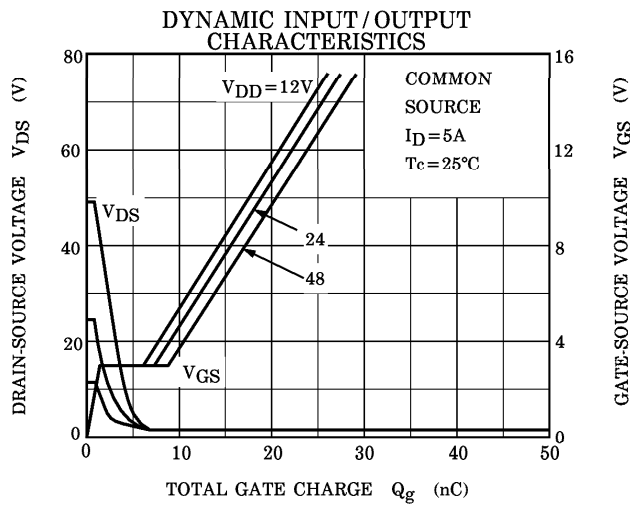
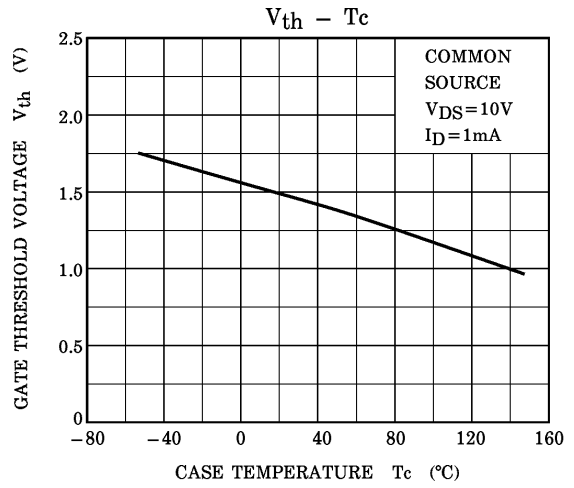
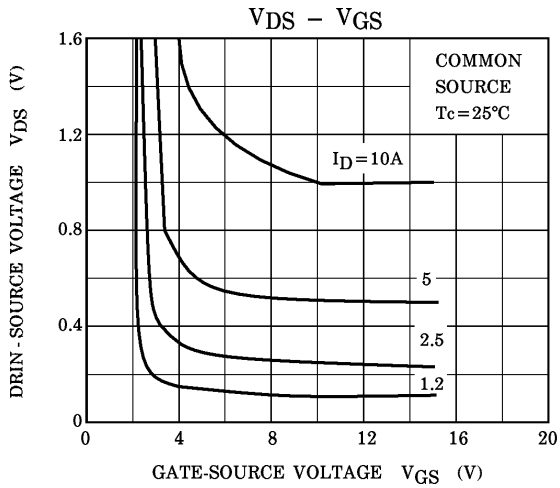
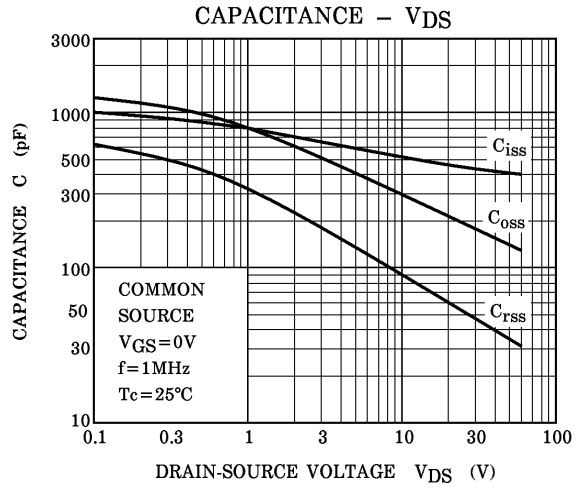
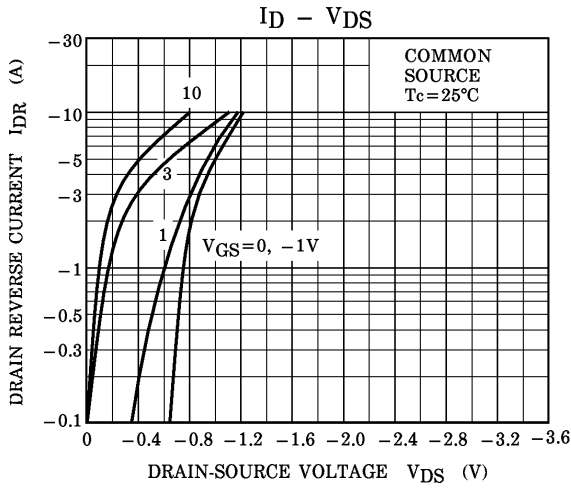
SOURCE-DRAIN DIODE RATINGS AND CHARACTERISTICS (Ta = 25°C)

| CHARACTERISTIC | SYMBOL | TEST CONDITION | MIN. | TYP. | MAX. | UNIT |
|----------------------------|-----------------|-----------------------|------|------|------|------|
| Drain Reverse Current | IDR | — | — | — | -5 | A |
| Peak Drain Reverse Current | IDRP | — | — | — | -20 | A |
| Diode Forward Voltage | VDSF | IDR = -5A, VGS = 0 | — | — | 1.5 | V |
| Reverse Recovery Time | t _{rr} | IDR = -5A, VGS = 0 | — | 120 | — | ns |
| Reverse Recovery Charge | Q _{rr} | dIDR / dt = -50A / μs | — | 0.24 | — | μC |

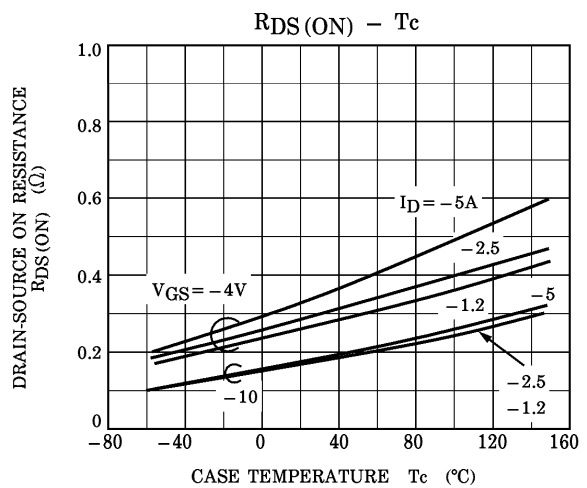
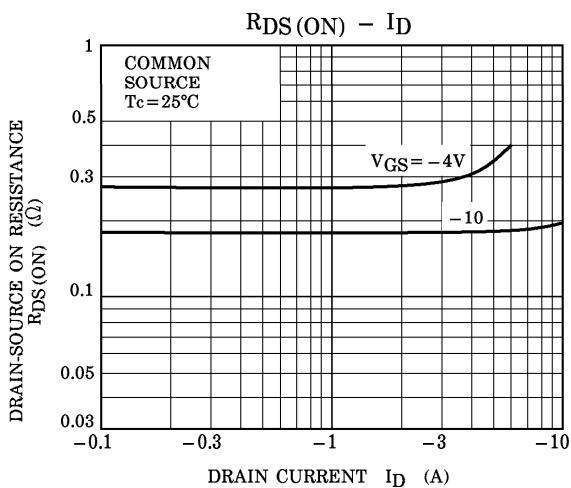
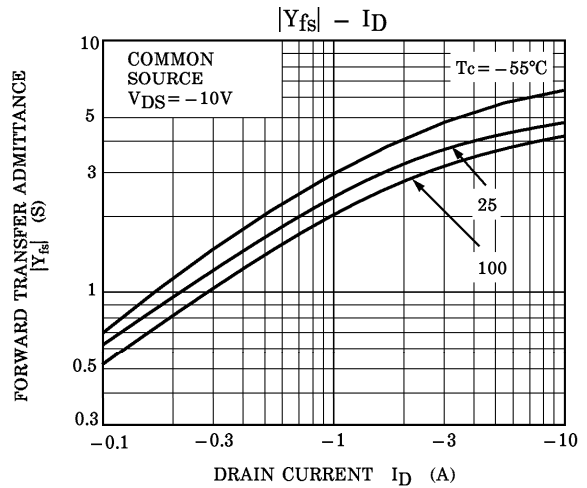
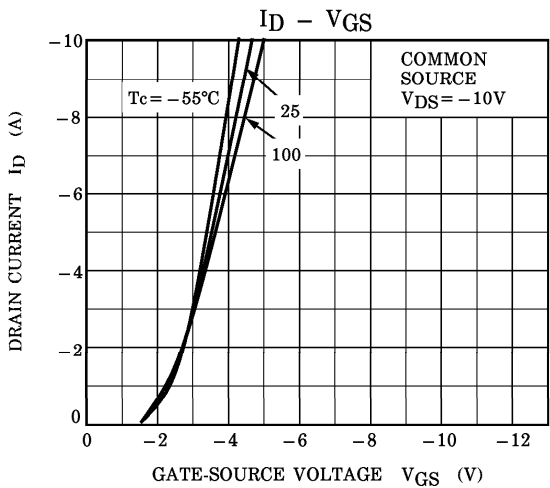
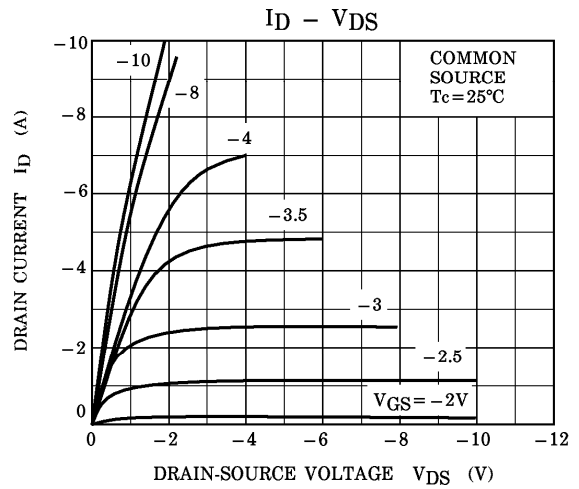
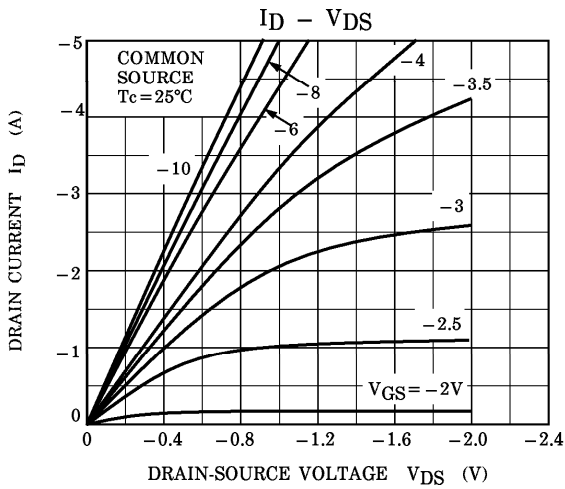
Nch FET



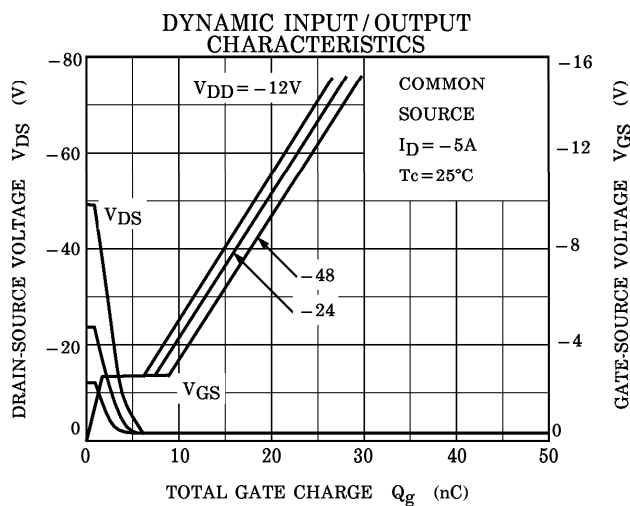
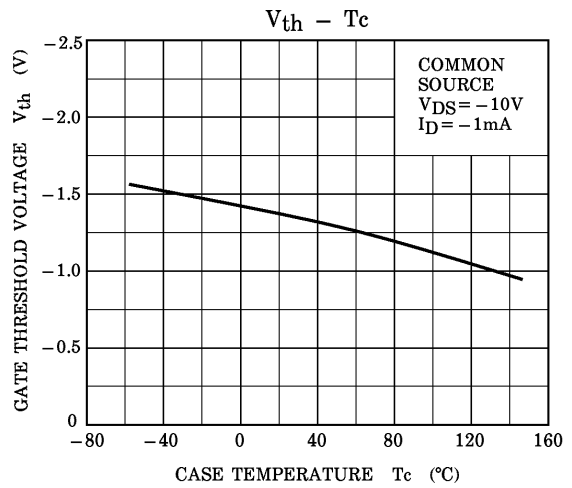
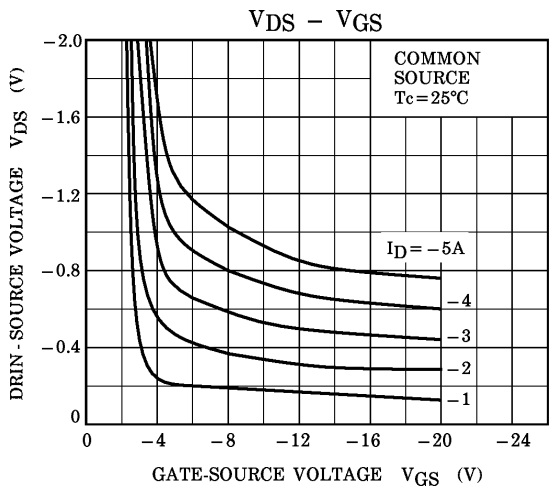
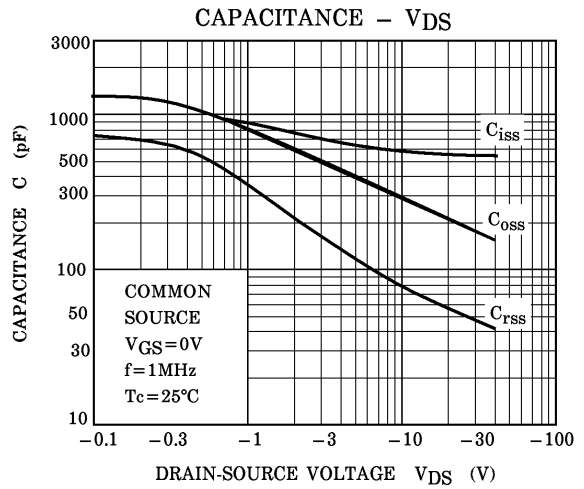
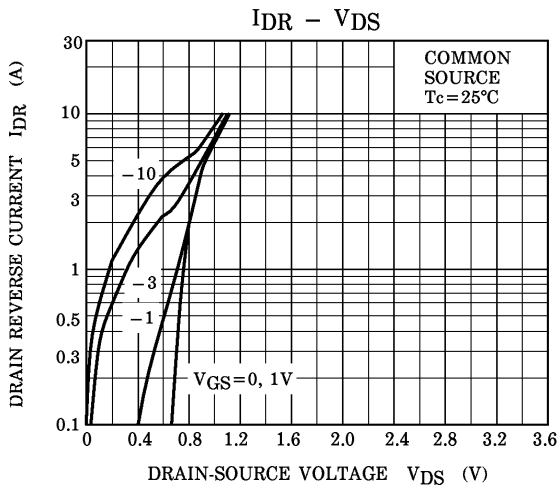
Nch FET

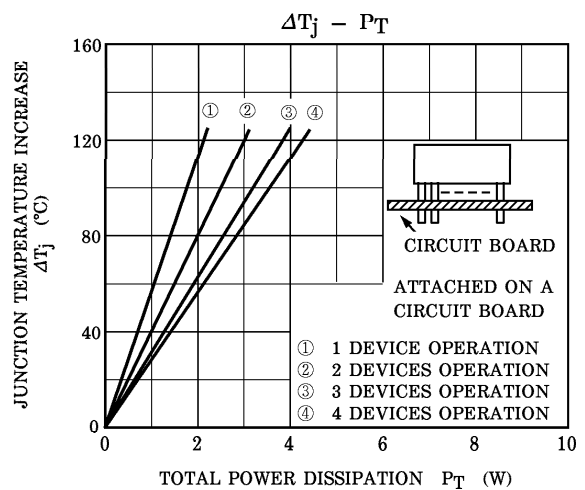
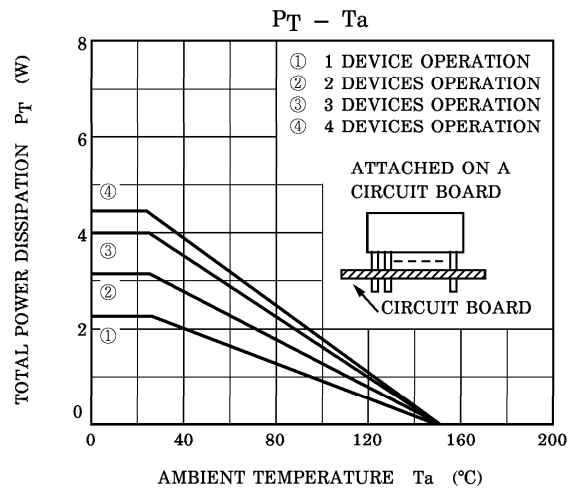
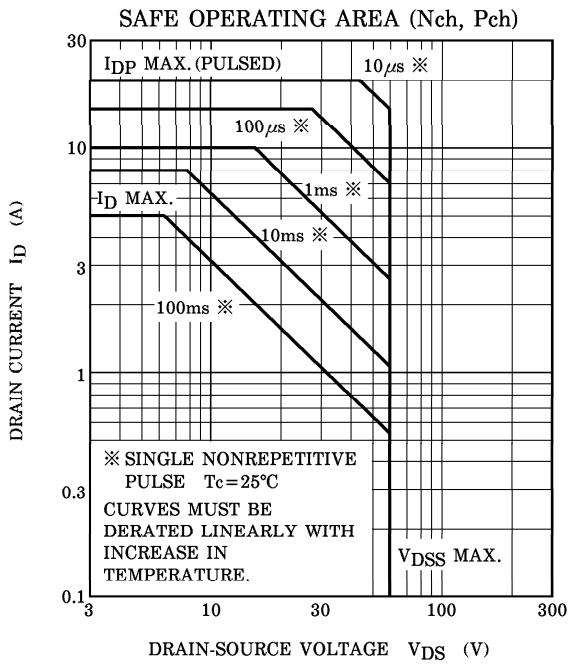
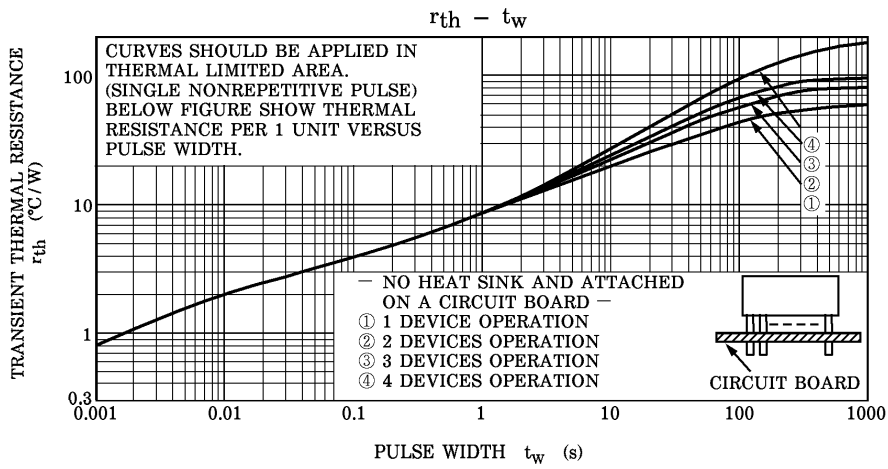


Pch FET



Pch FET





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